1. Scope

The SCC series X2, X1/Y2 safety capacitors are designed specifically for use in modem, facsimile, telephone and other electronic equipment.

These parts are compliant to EN60384-14, IEC60384-14 , UL60384-14 , CSA 60384-1 & CSA 60384-14.

(This product compliant with the RoHS and Pb free.)

2. Parts Number Code

SCC	1808	N	330	J	502	T	G
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)

(1)Product

Product Code	
SCC	Safety Approval of MLCC Product

(2)Chip Size

Code	Length×Width	unit : mm(inch)
1808	4.60× 2.00	(.18× .08)
1812	4.60× 3.20	(.18× .12)
2208	5.70× 2.00	(.22× .08)
2211	5.70× 2.80	(.22× .11)
2220	5.70× 5.00	(.22× .20)
2825	7.10× 6.35	(.28× .25)

(3)Temperature Characteristics

Code	Temperature Characteristic	Temperature Range	Temperature Coefficient
N	NPO	-55℃~+125℃	30 ppm/℃
X	X7R	-55℃~+125℃	± 15%

(4)Capacitance

unit :pico farads(pF)

Code	Nominal Capacitance (pF)
5R0	5.0
120	12.0
151	150.0
222	2,200.0
103	10,000.0

※. *If there is a decimal point, it shall be expressed by an English capital letter R*

(5)Capacitance Tolerance

Code	Tolerance	Nominal Capacitance
C	± 0.25 pF	Less Than 10 pF
D	± 0.50 pF	(Include 10 pF)
E	± 1.00 pF	
J	± 5.00 %	More Than 10 pF
K	± 10.0 %	
M	± 20.0 %	
Q	+10%~+20%	

(6) Class Level of Capacitors

Code	Class
202	X2
252	X2 (305Vac)
502	X1/Y2
602	X1/Y2 for SCC2208N,SCC2211N,SCC2220N Series

(7)Tapping

Code	Type
T	Tape & Reel
B	Bulk

(8)Special Requirement Code

Code	Type
G	Pb free Type

3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Tolerance		Nominal Capacitance
Class Ⅰ	NPO	Less Then 10 pF	C (± 0.25 pF)	0.5,1,1.5,2,2.5,3,3.5,4,4.5,5
			D (± 0.50 pF)	5,6,7,8,9,10
			E (± 1.00 pF)	6,7,8,9,10
		More Than 10 pF	J (± 5.00 %)	E-24 series
			K (± 10.0 %)	
Class Ⅱ	X7R	K (± 10.0 %), M (± 20.0 %)		E-12 series

3.2 E series(standard Number)

Standard No.	Application Capacitance											
E- 3	1.0				2.2				4.7			
E- 6	1.0		1.5		2.2		3.3		4.7		6.8	
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
Ⅰ	NPO	-55℃ ~ +125℃	25℃
Ⅱ	X7R	-55℃ ~ +125℃	25℃

5. Storage Condition

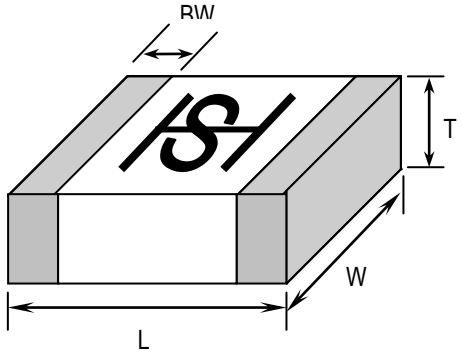
Storage Temperature：5 to 40℃

Relative Humidity：20 to 70 %

Storage Time：12 months max.

6. Dimensions

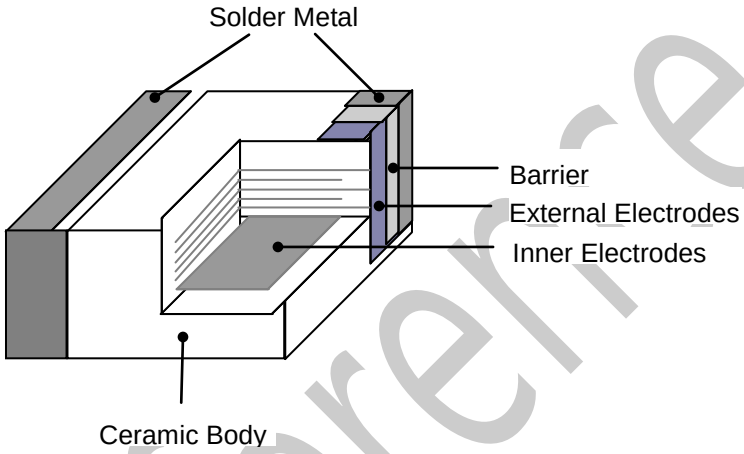
6.1 Configuration and Dimension：



Unit:mm

TYPE	L	W	T (max)	BW (min)
1808	4.60± 0.30	2.00± 0.20	2.20	0.20
1812	4.60± 0.30	3.20± 0.30	2.60	0.20
2208	5.70± 0.40	2.00± 0.20	2.20	0.30
2211	5.70± 0.40	2.80± 0.30	3.00	0.30
2220	5.70± 0.40	5.00± 0.40	3.00	0.30
2825	7.10± 0.30	6.35± 0.40	3.40	0.30

6.2 Termination Type：



7. Electronic Nominal Specification

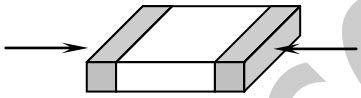
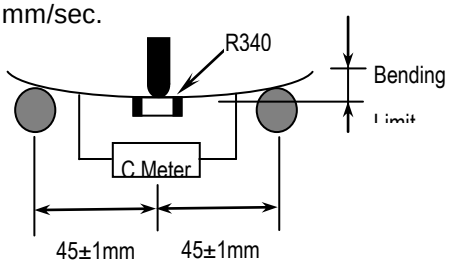
7.1 Safety Standard:

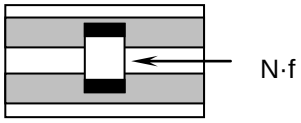
TUV : IEC 60384-14:2013 EN 60384-14:2013

UL :UL 60384-14 CSA 60384-1 & CSA 60384-14

Temperature Characteristic	Class	Size	Rated Voltage	Certificated	Capacitance Range (pF)
NPO	X2	1808	250 Vrms	TUV/UL	2 – 1000
X7R	X2	1808	250 Vrms	TUV/UL	150 – 2200
X7R	X2	1812	250 Vrms	TUV/UL	330 – 4700
X7R	X2	2220	250 Vrms	TUV/UL	150 – 33000
X7R	X2	2825	250 Vrms	UL	47000 – 56000
NPO	X1/Y2	1808	250 Vrms	TUV/UL	2 – 330
X7R	X1/Y2	1808	250 Vrms	TUV/UL	150 – 1000
NPO	X1/Y2	1812	250 Vrms	TUV/UL	2 – 680
X7R	X1/Y2	1812	250 Vrms	TUV/UL	130 – 1000
NPO	X1/Y2	2208	250 Vrms	TUV/UL	2 – 330
X7R	X1/Y2	2208	250 Vrms	TUV/UL	36 – 1000
NPO	X1/Y2	2211	250 Vrms	TUV/UL	2 – 1000
X7R	X1/Y2	2211	250 Vrms	TUV/UL	68 – 2700
NPO	X1/Y2	2220	250 Vrms	TUV/UL	2 – 1200
X7R	X1/Y2	2220	250 Vrms	TUV/UL	100 – 4700
X7R	X2	2220	305 Vrms	TUV/UL	150 – 33000

8. Performance

<table>
<tr><th>No.</th><th colspan="2">Item</th><th colspan="2">Specification</th><th>Test Condition</th></tr>
<tr><td>1</td><td colspan="2">Visual</td><td colspan="2">No abnormal exterior appearance</td><td>Visual Inspection</td></tr>
<tr><td>2</td><td colspan="2">Dimension</td><td colspan="2">See Page 3 / Item 6.</td><td>Visual Inspection</td></tr>
<tr><td>3</td><td colspan="2">Capacitance</td><td colspan="2">Within the specified tolerance</td><td>Char. Frequency Voltage</td></tr>
<tr><td rowspan="3">4</td><td colspan="2" rowspan="3">Q and
Dissipation Factor</td><td colspan="2" rowspan="3">Class Ⅰ (NPO)
More than 30pF : Q ≧1000
30pF & below: Q≧400＋20C (C:pF)
Class Ⅱ (X7R)
Maximum : 2.5% (0.025)</td><td>NPO
C≦1000pF 1MHz± 10% 1.0± 0.2Vrms
C＞1000pF 1KHz± 10%</td></tr>
<tr><td>X7R 1KHz± 10% 1.0± 0.2Vrms</td></tr>
<tr><td>After performing deage at 150±5% for 30min. and placement room temperature for 24±2hr.</td></tr>
<tr><td>5</td><td colspan="2">Insulation
Resistance</td><td colspan="2">Minimum 10,000MΩ</td><td>Applied Voltage:
Applied Voltage:500V Charge Time : 60sec.</td></tr>
<tr><td>6</td><td colspan="2">Voltage Proof</td><td colspan="2">No dielectric breakdown or mechanical breakdown</td><td>Applied Voltage:
X Capacitor :Applied Voltage 1075Vdc(4.3Ur)
Y Capacitor :Applied Voltage 1500Vac
For 1min.
Voltage ramp up rate≦150V/sec(for Vac Test)
charge/discharge Current is less than 50mA.</td></tr>
<tr><td>7</td><td colspan="2">Solderability</td><td colspan="2">More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve
  </td><td>Solder Temperature : 245± 5℃
Dip Time : 5 ± 0.5 sec.
Immersing Speed : 25±10% mm/s
Solder : Lead Free Solder
Flux :Rosin
Preheat : At 80~120 ℃ For 10~30sec.</td></tr>
<tr><td rowspan="6">8</td><td rowspan="6">Resistance to Flexure of Substrate</td><td>Appear-ance</td><td colspan="2">No mechanical damage shall occur.</td><td rowspan="6">Bending shall be applied to the 1.0 mm with 1.0 mm/sec.
 

Solder the capacitor on P.C. board shown in Fig 1. before testing.</td></tr>
<tr><td rowspan="3">Capacit-ance</td><td>Characteristic</td><td>Cap. Change</td></tr>
<tr><td>Class Ⅰ (NPO)</td><td>≤ ± 5.0% of initial value</td></tr>
<tr><td>Class Ⅱ (X7R)</td><td>≤ ± 12.5% of initial value</td></tr>
<tr><td>Q / tanδ</td><td colspan="2">To satisfy the specified initial value</td></tr>
<tr><td>Insulation Resistance</td><td colspan="2">To satisfy the specified initial value</td></tr>
<tr><td>Voltage Proof</td><td colspan="2">To satisfy the specified initial value</td></tr>
<tr><td rowspan="6">9</td><td rowspan="6">Robustness of Shear</td><td>Appear-ance</td><td colspan="2">No indication of peeling shall occur on the terminal electrode.</td><td rowspan="6">Pull force shall be applied for 10± 1 second.
≦0603----5N(≒ 0.5 Kg·f)
＞0603----10N(≒1.0 Kg·f)
 

Solder the capacitor on P.C. board shown in Fig 1. before testing.</td></tr>
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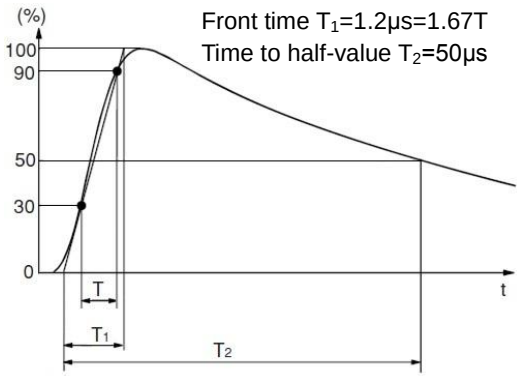
<tr><td>Q / tanδ</td><td colspan="2">To Satisfy The Specified Initial Value</td></tr>
<tr><td>Insulation Resistance</td><td colspan="2">To Satisfy The Specified Initial Value</td></tr>
<tr><td>Voltage Proof</td><td colspan="2">To Satisfy The Specified Initial Value</td></tr>
</table>

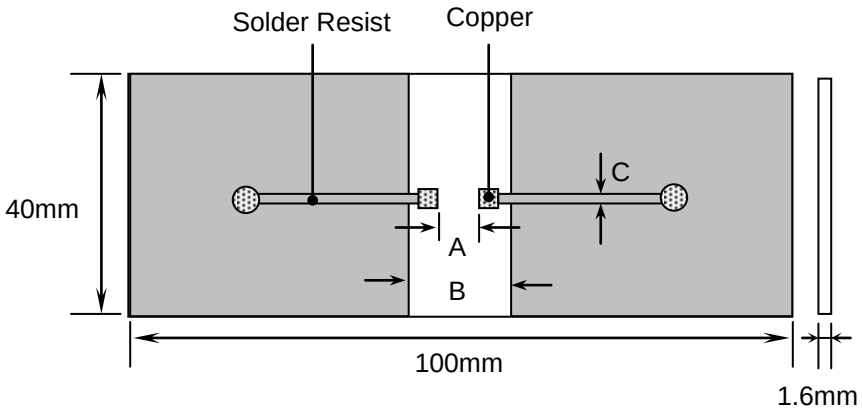
No.	Item		Specification		Test Condition
10	Resistance To Soldering Heat	Appear-ance	No mechanical damage shall occur.		Class Ⅱ capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 +0/-10℃ before initial measure. Preheat : At 150± 10℃ For 60~120sec. Dip : Solder Temperature of 260± 5℃ Dip Time : 10 ± 1sec. Flux :Rosin Measure at room temp. after cooling for: Class Ⅰ : 24 ± 2 Hours Class Ⅱ : 48 ± 4 Hours
		Capacit-ance	Characteristic	Cap. Change	
			Class Ⅰ (NPO)	≤ ± 10% of initial value	
			Class Ⅱ (X7R)	≤ ± 20% of initial value	
		Q / Tanδ	To satisfy the specified initial value		
		Insulation Resistance	More than 1,000MΩ		
		Voltage Proof	To Satisfy The Specified Initial Value		
11	Damp Heat / Steady State	Appear-ance	No mechanical damage shall occur.		Test Condition : Temperature : 40℃ Humidity : 95 %RH Test Time : 500hr (21days) The capacitors with rated voltage(250Vac) applied. Measure at room temp. after cooling for: Class Ⅰ :24 ± 2 Hrs Class Ⅱ :48 ± 4 Hrs Solder The Capacitor On P.C. Board Shown In Fig 2. Before Testing.
		Capacit-ance	Characteristic	Cap. Change	
			Class Ⅰ (NPO)	≤ ± 15% of initial value	
			Class Ⅱ (X7R)	≤ ± 15% of initial value	
		Q Class Ⅰ	More Than 30pF : Q ≧ 350 30pF & Below:Q ≧ 275+2.5× C (C:pF)		
		Tan δ Class Ⅱ	Maximum 5.0%		
		Insulation Resistance	More Than 1,000MΩ		
		Voltage Proof	To Satisfy The Specified Initial Value		
12	Endurance	Appear-ance	No Mechanical Damage Shall Be Occur		Impulse Voltage Each individual capacitor shall be subjected to a 2.5KV(X2) and 5KV(X1/Y2) impulse for three times. Then the capacitors are applied to life test.
		Capacit-ance	Characteristic	Cap. Change	
			Class Ⅰ (NPO)	≤ ± 20% of initial value	
			Class Ⅱ (X7R)	≤ ± 20% of initial value	
		Q Class Ⅰ	More Than 30pF : Q ≧ 350 30pF & Below:Q ≧ 275+2.5×C (C:pF)		
		Tan δ Class Ⅱ	Maximum 5.0%		
		Insulation Resistance	Minimum 1,000MΩ		

		Voltage Proof	To satisfy the specified initial value	 Front time T_1=1.2μs=1.67T Time to half-value T_2=50μs Temperature : 125℃ Test Time : 1000hrs Applied Voltage : Class X Capacitors :1.25Ur (312.5Vac) Class Y Capacitors :1.70Ur (425Vac) Except that once every hour the voltage shall be increased to 1000Vrms for 0.1s.

No.	Item	Specification	Test Condition
13	Passive Flammability	Capacitor didn't burnt at all	Volume Sample : 21.56mm^3 Flame exposure time : 5 sec.Max.
14	Active Flammability	The cheese cloth shall not burn with a flame	The capacitors of class each test capacitors applied Ur(250Vac). Then each sample shall be subjected to 20 discharges from a tank capacitor, charge to a voltage that, when discharged, places Ui(2500V) across the capacitor under test. The interval between successive discharges shall be 5s.

Fig.1

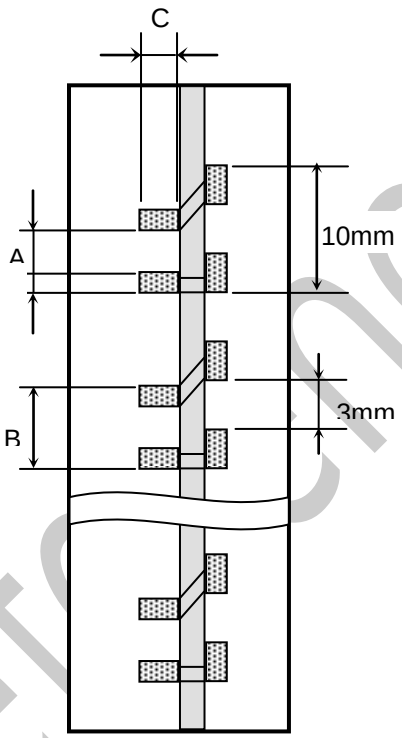
P.C. Board for Bending Strength Test *(referring to IEC384-14 and EN132400)*



Material : Glass Epoxy Substrate
: Copper (Thickness : 0.035mm)
: Solder Resist

Fig.2

Test Substrate



Material : Glass Epoxy Substrate
: Copper (Thickness : 0.035mm)
: Solder Resist
Thickness : 1.6 mm

Unit:mm

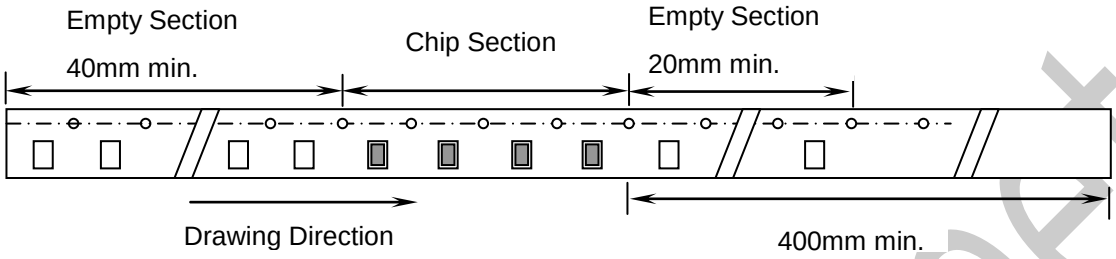
Type	A	B	C
1206	2.2	5.0	2.0
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6

9. Packing

9.1 Bulk Packing

According to customer request.

9.2 Chip Capacitors Tape Packing



9.3 Material And Quantity

Tape / Material	1206		
	T≦0.90mm	0.90mm＜T≦1.25mm	T＞1.25mm
Plastic	4,000 pcs/Reel	3,000 pcs/Reel	2,000 pcs/Reel

Tape / Material	1808		1812/2208/2211/2220	
	0.9mm＜T≦1.25mm	1.25mm＜T≦2.0mm	1.25mm＜T≦2.2mm	T＞2.2mm
Plastic	3000 pcs/Reel	2000 pcs/Reel	1000 pcs/Reel	700 pcs/Reel

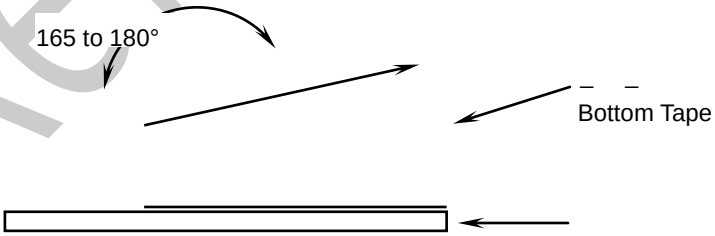
Tape / Material	2825
	T＞2.6mm
Plastic	400 pcs/Reel

9.4 Cover Tape Reel Off Force

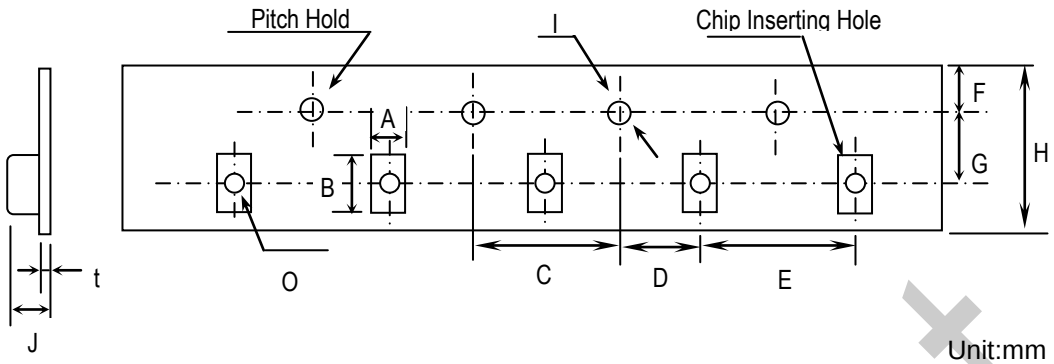
9.4.1 Peel-Off Force

5 g·f ≦Peel-Off Force ≦70 g·f

9.4.2 Measure Method



9.5 Plastic Tape



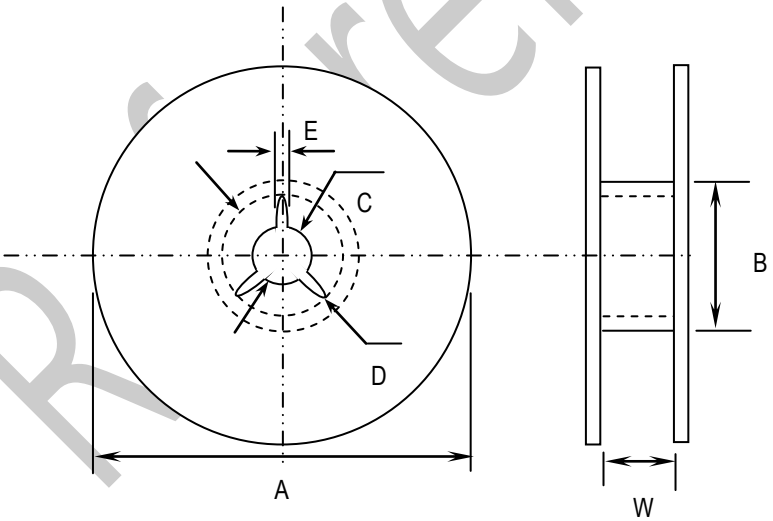
Unit:mm

Type	A	B	C	D	E	F
1206	1.9± 0.2	3.5± 0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2825	6.7±0.2	7.5±0.2			12.0± 0.1	

Type	G	H	I	J	t	O
1206	5.5± 0.05	12.0 ± 0.3	φ 1.5+0.1/-0	3.7 max.	0.3 max.	1.0± 0.1
1808						1.5± 0.1
1812						
2208						
2211						
2220						
2825	7.5± 0.10	16.0 ± 0.3			0.35 max.	

9.6 Reel Dimensions

Reel Material：Polystyrene



Unit:mm

Type	A	B	C	D	E	W
1206	178± 2.0	φ 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	14± 0.15
1808						
1812						
2208						
2211						
2220						
2825						

Caution

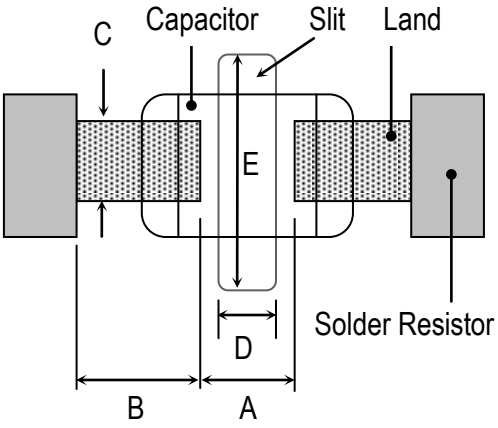
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40°C and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering.



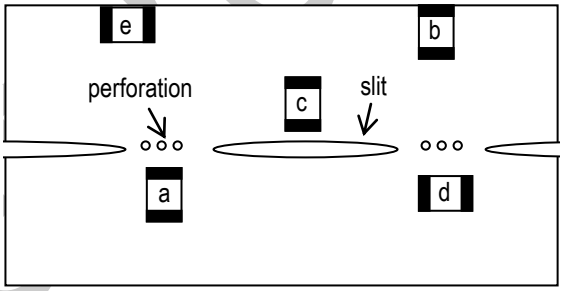
EIA Code	Chip (mm)		Land (mm)				
	L	W	A	B	C	D	E
1808	4.60	2.00	2.8~3.4	1.2~1.4	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.2~1.4	2.3~3.0	1.0~2.8	4.8~5.3
2208	5.70	2.00	4.0~4.6	1.4~1.6	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	1.4~1.6	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	1.4~1.6	3.5~4.8	1.0~4.0	6.6~7.1

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

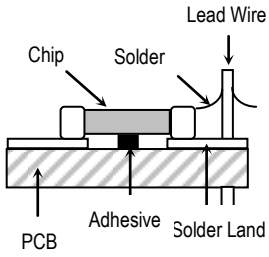
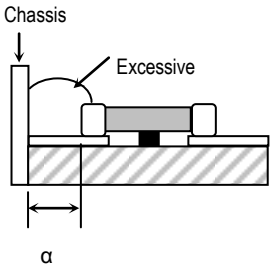
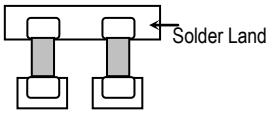
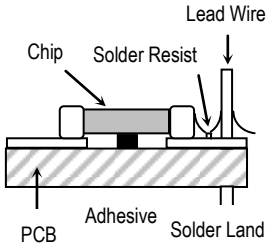
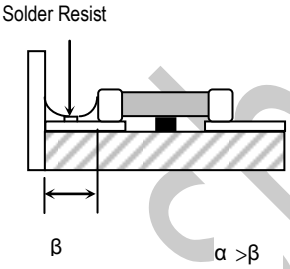
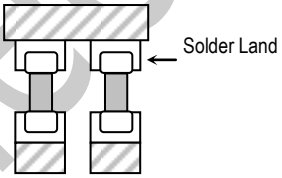
Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended.

Susceptibility to stress is in the order of: a>b>c and d>e



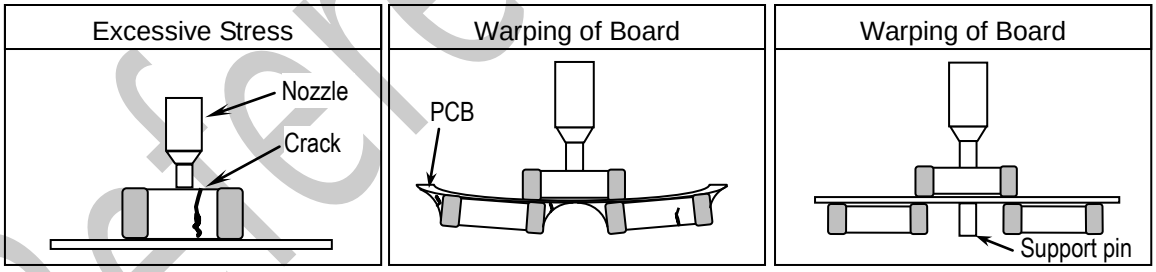
2.3 Layout Recommendation

Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid			
Recommendation			

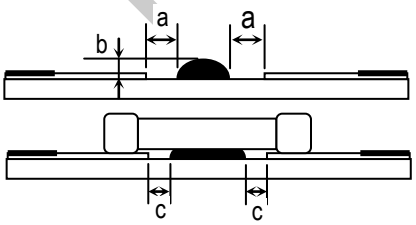
3. Mounting

3.1 Sometimes Crack is caused by the impact load due to suction nozzle in pick and place operation.

In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



Example : 0805 & 1206

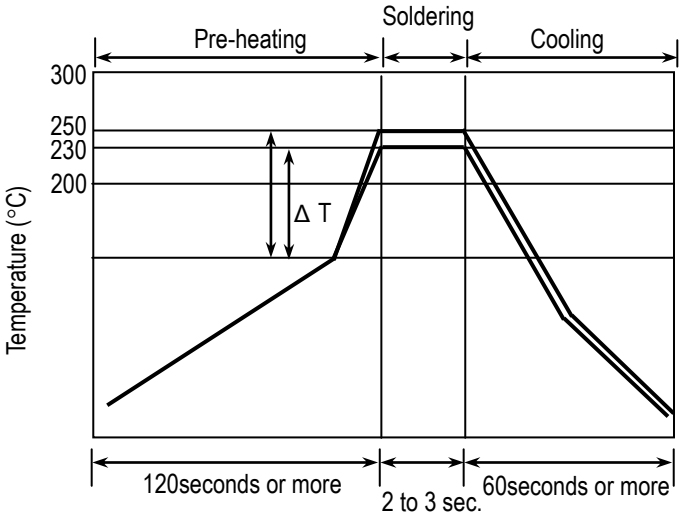
a	0.2mm min.
b	70 ~ 100 μm
c	Do not touch the solder land

4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to 250°C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Change in Temp.(℃)
1206 and Under	Δ T ≤ 100~130 max

When setting preheat temperatures, that recommend as preheat conditions which can pass the following points for PCB.

1) Preheat temperature is too low
   a. Flux flows to easily
   b. Possibility of thermal cracks
2) Preheat temperature is too high
   a. Flux deteriorates even when oxide film is removed
   b. Too large a warp in circuit board
   c. Loss of reliability in chip and other parts

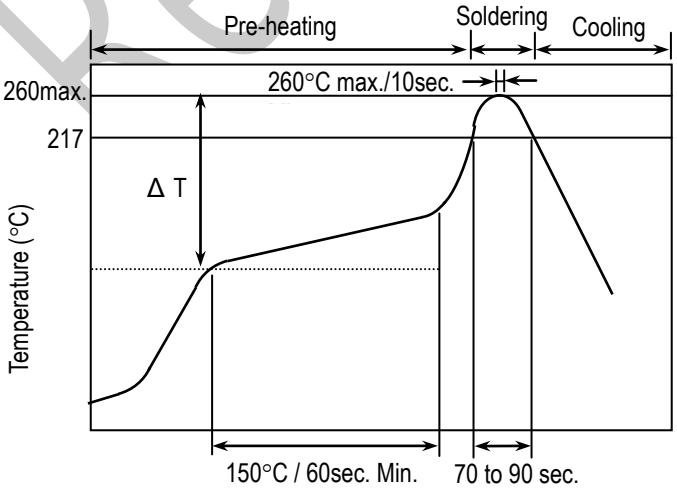
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) must be less than 100℃

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component; however it should not exceed 3°C/Sec.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)

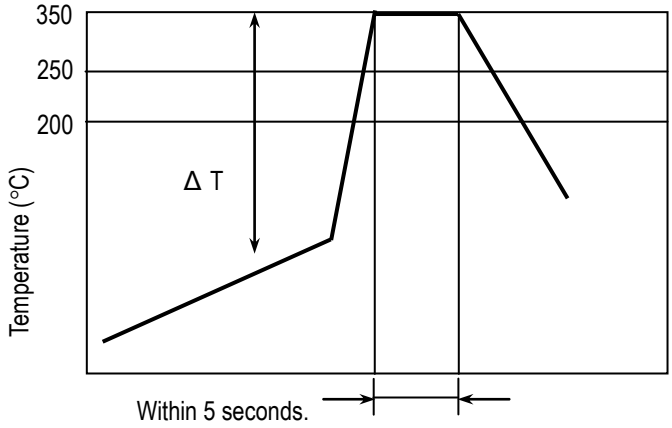


※ The cycles of soldering : Twice (max.)

Soldering Method	Change in Temp.(℃)
1206 and Under	Δ T ≦ 190 ℃
1210 and Over	Δ T ≦ 130 ℃

4.3 Hand Soldering

Sudden heating of the components results in distortion due to a high internal temperature differential, causing cracked chips. When preheating, keep temperature differentialΔ T, within the range shown in table. The smaller theΔ T, the less stress on the chip.



Soldering Method	Change in Temp.(℃)
1206 and Under	Δ T ≦ 150 ℃
1210 and Over	Δ T ≦ 130 ℃

How to Solder Repair by Solder Iron

1) Selection of the soldering iron tip

Tip temperature of solder iron various by its type , P.C.board material and solder land size. Higher the tip temperature, quick the operation is .but the heat shock may crack the chip capacitor.

2) recommended solder iron condition

a.) Preheating Condition：Board and components should be preheated sufficiently at 150°C or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.

b.) Soldering iron power shall not exceed 30 W.

c.) Soldering iron tip diameter shall not exceed 3mm.

d.) Temperature of iron tip shall not exceed 350℃and the process should be finished within 5 seconds. (refer to MIL-STD-202G)

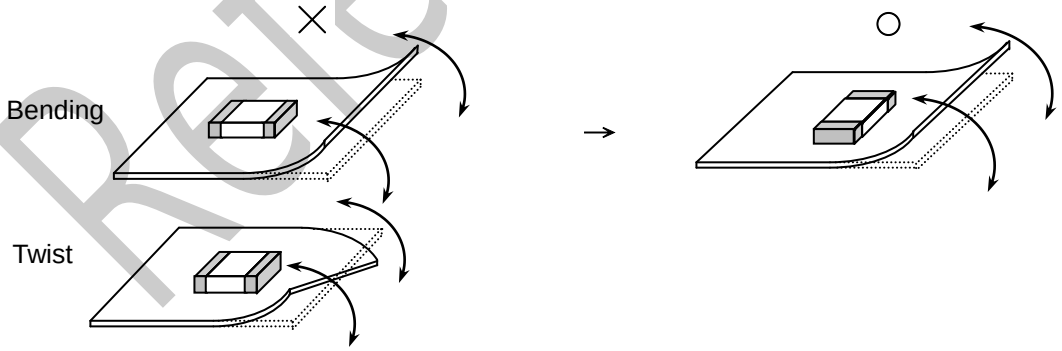
e.) Do not touch the ceramic dielectric with solder iron other than the terminations. Direct contact of the soldering iron with ceramic dielectric of chip capacitor may cause crack.

f.) After soldering ,let the products to cool down gradually in the room temperature.

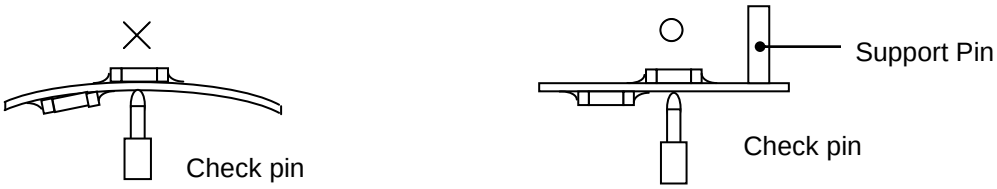
※ The soldering to lose the use of electronic heat gun.

5. Handling after chip mounted

5.1 Please pay attention put the component lateral to the direction in which stress acts.



5.2 Crack will be caused if board is warped due to excessive load by check pin.

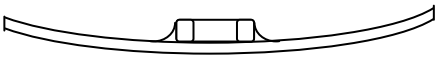


5.3 Mechanical stress due to warping and torsion by dividing.

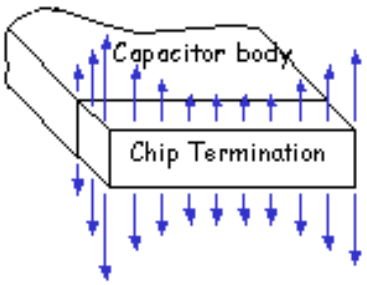
(a) Crack occurrence ratio will be increased by manual separation.

(b) Crack occurrence ratio will be increased by tensile force , rather than compressive force.

╳ :Tensile Stress ○ :Compressive Stress



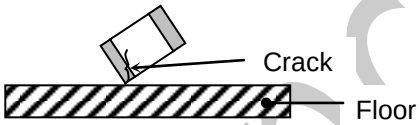
Capacitor Stress Analysis



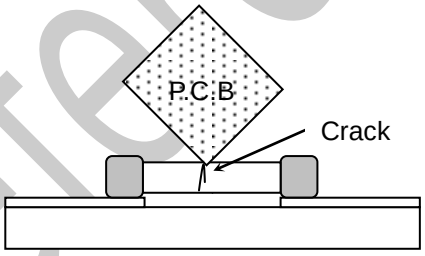
Failure mode: chip crack by stress

6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 Piling the P.C. board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor of another of board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep storage temperature +5 ~+40℃ , Humidity 20 ~70%RH and use them within 12 months.